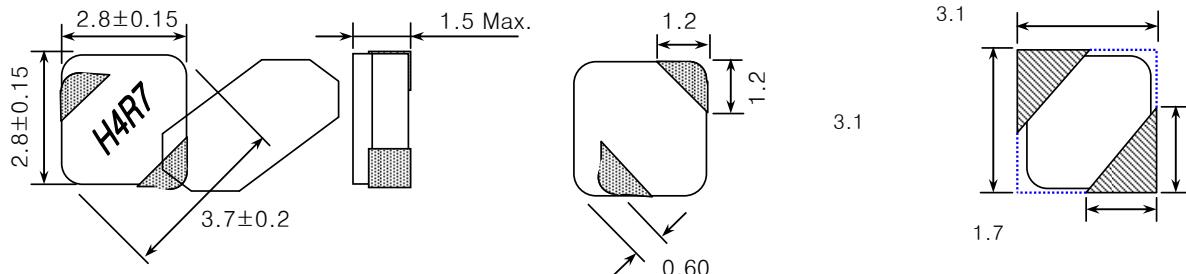


SMD Shielded type

▼ Shape & Dimensions / Recommended Solder Land Pattern

(Dimensions in mm)



▼ Electrical Characteristics

() is typical value.

Ordering Code	Inductance		Freq. (KHz)	DC Resistance(Ω) (Max.)	DC current(A)		Marking	
	L (uH)	Tol. (%)			I _{dc1} (Max.)	I _{dc2} (Typ.)		
LPF3015T-1R5N-C	1.5	±30	100	0.069(0.062)	1.65	1.65	H1R5	
LPF3015T-2R2M-C	2.2	±20		0.098(0.084)	1.40	1.40	H2R2	
LPF3015T-3R3M-C	3.3			0.140(0.123)	1.10	1.20	H3R3	
LPF3015T-4R7M-C	4.7			0.190(0.172)	0.90	1.10	H4R7	
LPF3015T-6R8M-C	6.8			0.290(0.272)	0.85	0.90	H6R8	
LPF3015T-100M-C	10	±20	100	0.410(0.386)	0.68	0.75	H100	
LPF3015T-150M-C	15			0.520(0.497)	0.58	0.65	H150	
LPF3015T-220M-C	22			0.830(0.764)	0.48	0.50	H220	
LPF3015T-330M-C	33			1.250(1.116)	0.35	0.40	H330	
LPF3015T-470M-C	47			1.980(1.835)	0.30	0.30	H470	

▼ Test Equipments

- . L : Agilent E4980A Precision LCR Meter
- . Rdc : HIOKI 3540 mΩ HiTESTER
- . I_{dc1} : Agilent 4284A LCR Meter + Agilent 42841A Bias Current Source
- . I_{dc2} : Yokogawa DR130 Hybrid Recorder + Agilent 6692A DC Power Supply

□ Packing style

T : Taping B : Bulk

▼ Test Condition

- . L(Frequency , Voltage) : F=100 (KHz) , V=0.5 (V)
- . I_{dc1}(The saturation current) : $\Delta L \leq 35\%$ reduction from nominal L value
- . I_{dc2}(The temperature rise) : $\Delta T = 40^\circ\text{C}$ typical at rated DC current
- * Rated DC current(I_{dc}) : The value of I_{dc1} or I_{dc2} , whichever is smaller

▼ Operating Temperature Range

-30 ~ +85°C (Including self-generated heat)